

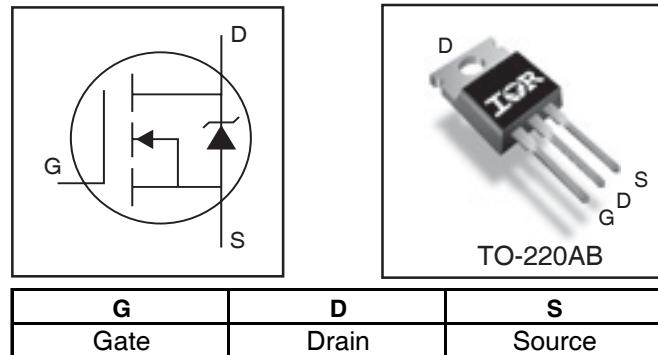
PDP SWITCH

# IRFB4332PbF

## Features

- Advanced Process Technology
- Key Parameters Optimized for PDP Sustain, Energy Recovery and Pass Switch Applications
- Low  $E_{PULSE}$  Rating to Reduce Power Dissipation in PDP Sustain, Energy Recovery and Pass Switch Applications
- Low  $Q_G$  for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- 175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

Key Parameters		
$V_{DS\ min}$	250	V
$V_{DS\ (Avalanche)\ typ.}$	300	V
$R_{DS(ON)}\ typ.\ @\ 10V$	29	mΩ
$T_J\ max$	175	°C



## Description

This HEXFET® Power MOSFET is specifically designed for Sustain; Energy Recovery & Pass switch applications in Plasma Display Panels. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area and low  $E_{PULSE}$  rating. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications.

## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{GS}$	Gate-to-Source Voltage	±30	V
$I_D\ @\ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	60	A
$I_D\ @\ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	42	
$I_{DM}$	Pulsed Drain Current ①	230	
$I_{RP}\ @\ T_C = 100^\circ C$	Repetitive Peak Current ⑤⑥	120	
$P_D\ @T_C = 25^\circ C$	Power Dissipation	390	W
$P_D\ @T_C = 100^\circ C$	Power Dissipation	200	
	Linear Derating Factor	2.6	W/°C
$T_J$	Operating Junction and	-40 to + 175	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature for 10 seconds	300	
	Mounting Torque, 6-32 or M3 Screw	10lb·in (1.1N·m)	

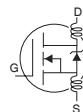
## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ④	—	0.38	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient ④	—	62	

Notes ① through ⑥ are on page 8

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

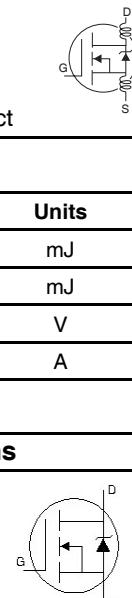
	Parameter	Min.	Typ.	Max.	Units	Conditions
$\text{BV}_{\text{DSS}}$	Drain-to-Source Breakdown Voltage	250	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	170	—	mV/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, \text{I}_D = 1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	—	29	33	$\text{m}\Omega$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 35\text{A}$ ③
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	3.0	—	5.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{V}_{\text{GS(th)}}/\Delta T_J$	Gate Threshold Voltage Coefficient	—	-14	—	mV/ $^\circ\text{C}$	
$\text{I}_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$\text{V}_{\text{DS}} = 250\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	1.0	mA	$\text{V}_{\text{DS}} = 250\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
$\text{I}_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	nA	$\text{V}_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100	nA	$\text{V}_{\text{GS}} = -20\text{V}$
$\text{g}_{\text{fs}}$	Forward Transconductance	100	—	—	S	$\text{V}_{\text{DS}} = 25\text{V}, \text{I}_D = 35\text{A}$
$\text{Q}_g$	Total Gate Charge	—	99	150	nC	$\text{V}_{\text{DD}} = 125\text{V}, \text{I}_D = 35\text{A}, \text{V}_{\text{GS}} = 10\text{V}$ ③
$\text{Q}_{\text{gd}}$	Gate-to-Drain Charge	—	35	—		
$t_{\text{st}}$	Shoot Through Blocking Time	100	—	—	ns	$\text{V}_{\text{DD}} = 200\text{V}, \text{V}_{\text{GS}} = 15\text{V}, R_G = 4.7\Omega$
$E_{\text{PULSE}}$	Energy per Pulse	—	520	—	$\mu\text{J}$	$L = 220\text{nH}, C = 0.3\mu\text{F}, \text{V}_{\text{GS}} = 15\text{V}$
		—	920	—	$\mu\text{J}$	$\text{V}_{\text{DS}} = 200\text{V}, R_G = 5.1\Omega, T_J = 25^\circ\text{C}$
$C_{\text{iss}}$	Input Capacitance	—	5860	—	$\text{pF}$	$L = 220\text{nH}, C = 0.3\mu\text{F}, \text{V}_{\text{GS}} = 15\text{V}$
	Output Capacitance	—	530	—	$\text{pF}$	$\text{V}_{\text{DS}} = 200\text{V}, R_G = 5.1\Omega, T_J = 100^\circ\text{C}$
	Reverse Transfer Capacitance	—	130	—	$\text{pF}$	$f = 1.0\text{MHz},$
	Effective Output Capacitance	—	360	—	$\text{pF}$	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 0\text{V to } 200\text{V}$
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.)
$L_S$	Internal Source Inductance	—	7.5	—	nH	from package and center of die contact

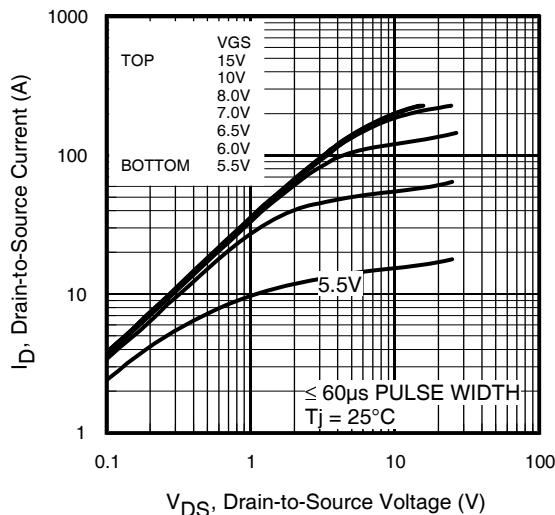
**Avalanche Characteristics**

	Parameter	Typ.	Max.	Units
$E_{\text{AS}}$	Single Pulse Avalanche Energy ②	—	230	mJ
$E_{\text{AR}}$	Repetitive Avalanche Energy ①	—	39	mJ
$\text{V}_{\text{DS(Avalanche)}}$	Repetitive Avalanche Voltage ①	300	—	V
$I_{\text{AS}}$	Avalanche Current ②	—	35	A

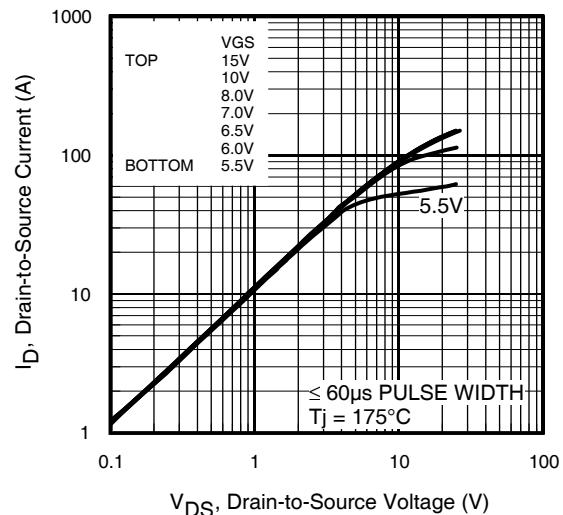
**Diode Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s @ T_C = 25^\circ\text{C}$	Continuous Source Current (Body Diode)	—	—	60	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	230	A	
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_s = 35\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ③
$t_{\text{rr}}$	Reverse Recovery Time	—	190	290	ns	$T_J = 25^\circ\text{C}, I_F = 35\text{A}, \text{V}_{\text{DD}} = 50\text{V}$
$Q_{\text{rr}}$	Reverse Recovery Charge	—	820	1230	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ③

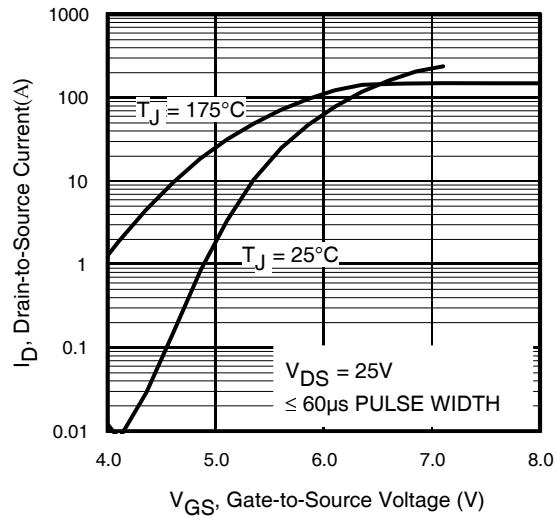




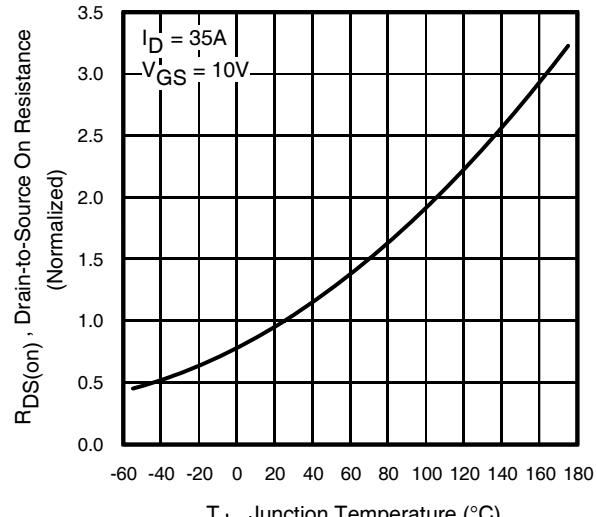
**Fig 1.** Typical Output Characteristics



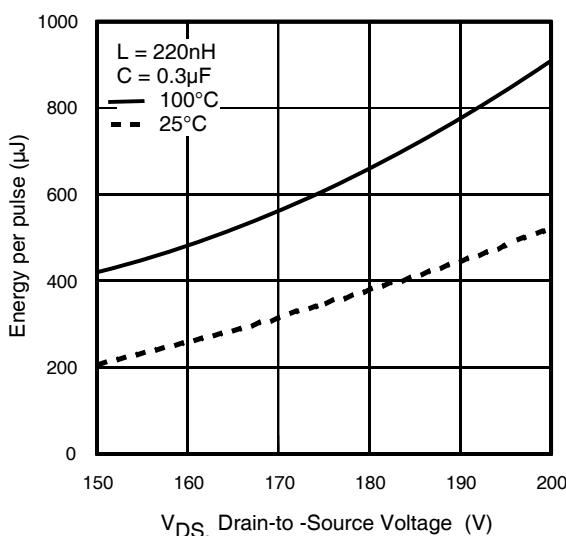
**Fig 2.** Typical Output Characteristics



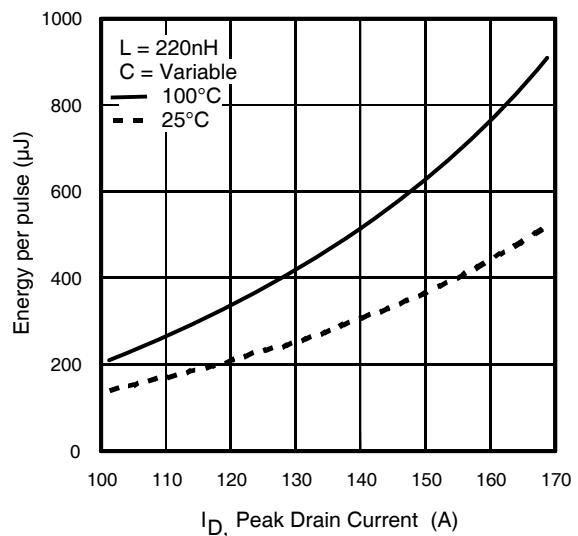
**Fig 3.** Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance vs. Temperature



**Fig 5.** Typical  $E_{PULSE}$  vs. Drain-to-Source Voltage



**Fig 6.** Typical  $E_{PULSE}$  vs. Drain Current

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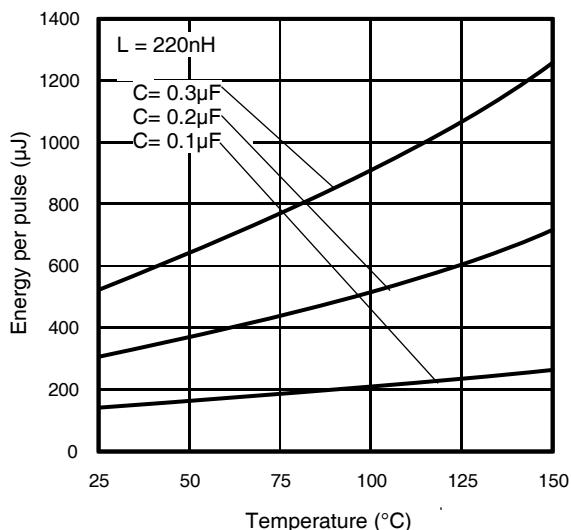


Fig 7. Typical  $E_{\text{PULSE}}$  vs.Temperature

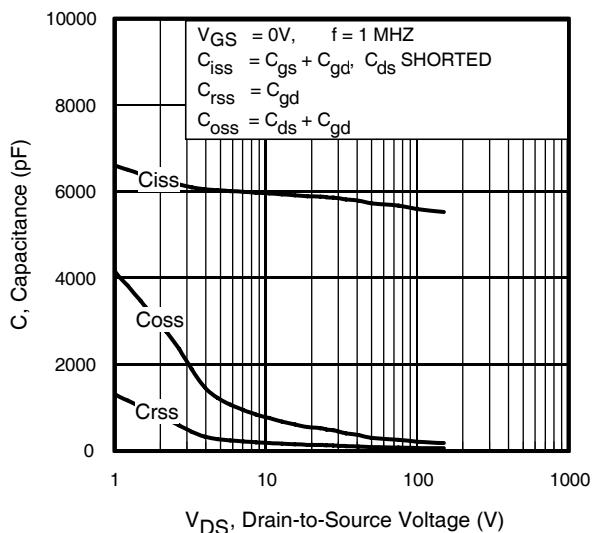


Fig 9. Typical Capacitance vs.Drain-to-Source Voltage

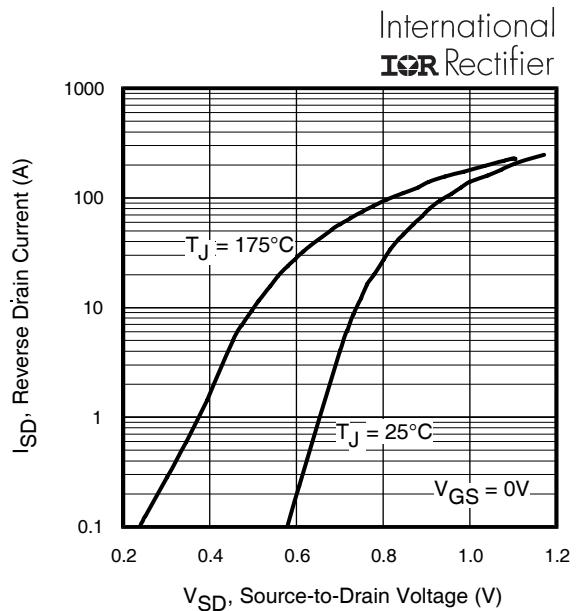


Fig 8. Typical Source-Drain Diode Forward Voltage

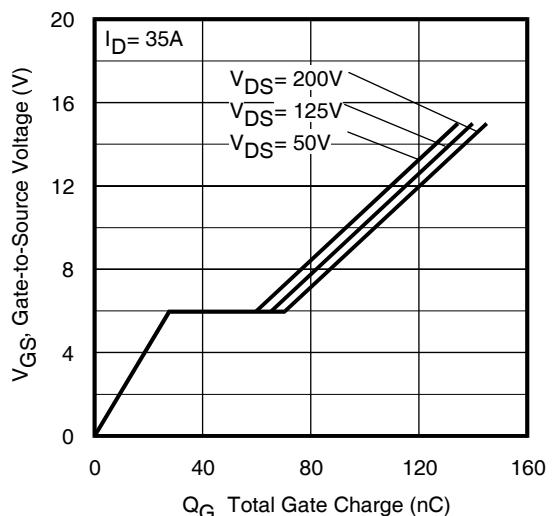


Fig 10. Typical Gate Charge vs.Gate-to-Source Voltage

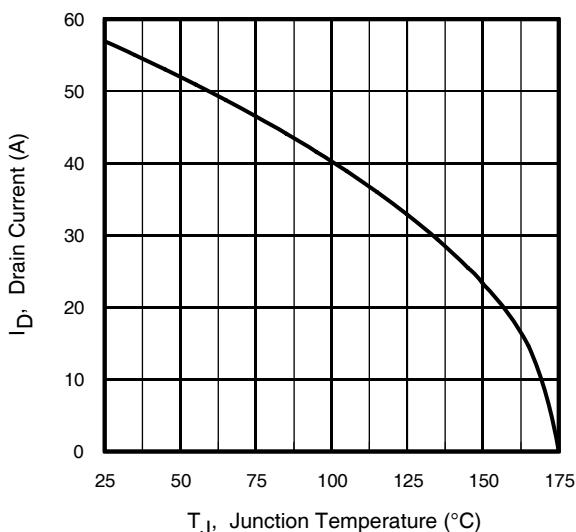


Fig 11. Maximum Drain Current vs. Case Temperature

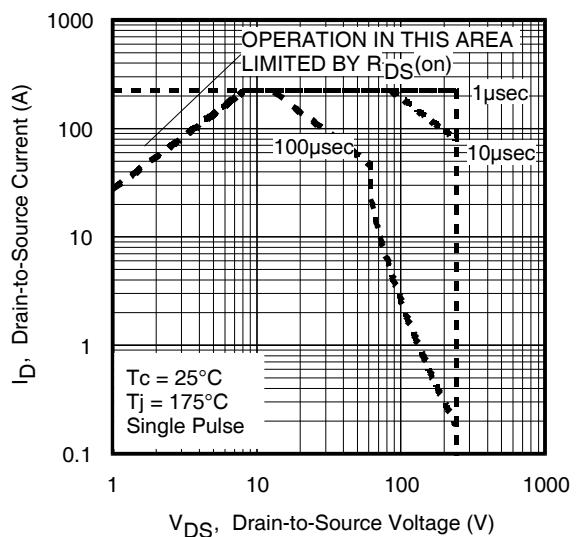


Fig 12. Maximum Safe Operating Area

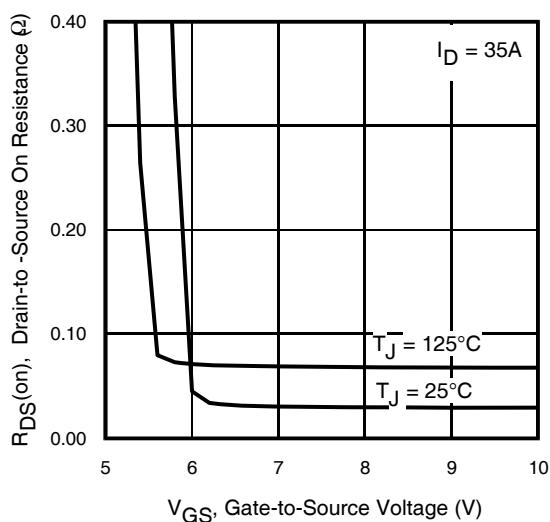


Fig 13. On-Resistance Vs. Gate Voltage

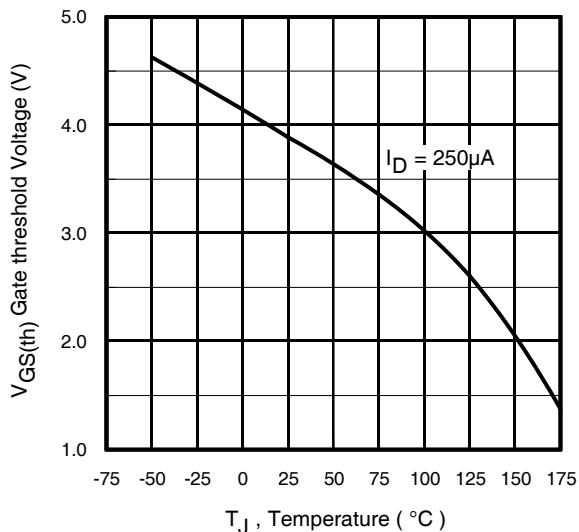


Fig 15. Threshold Voltage vs. Temperature

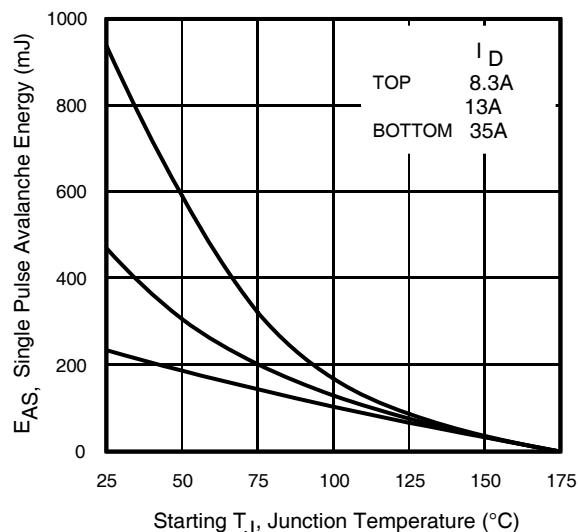


Fig 14. Maximum Avalanche Energy Vs. Temperature

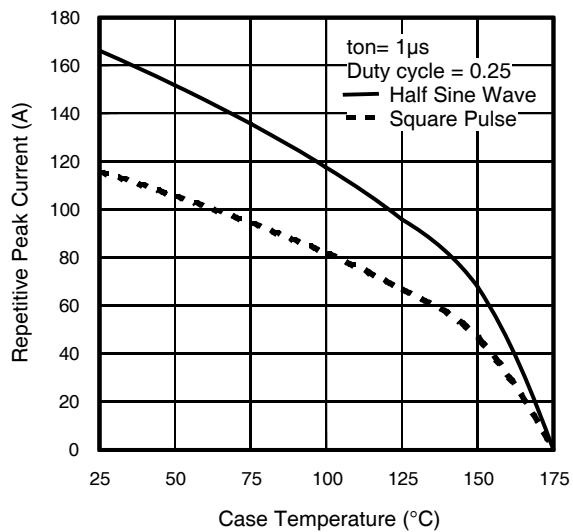


Fig 16. Typical Repetitive peak Current vs. Case temperature

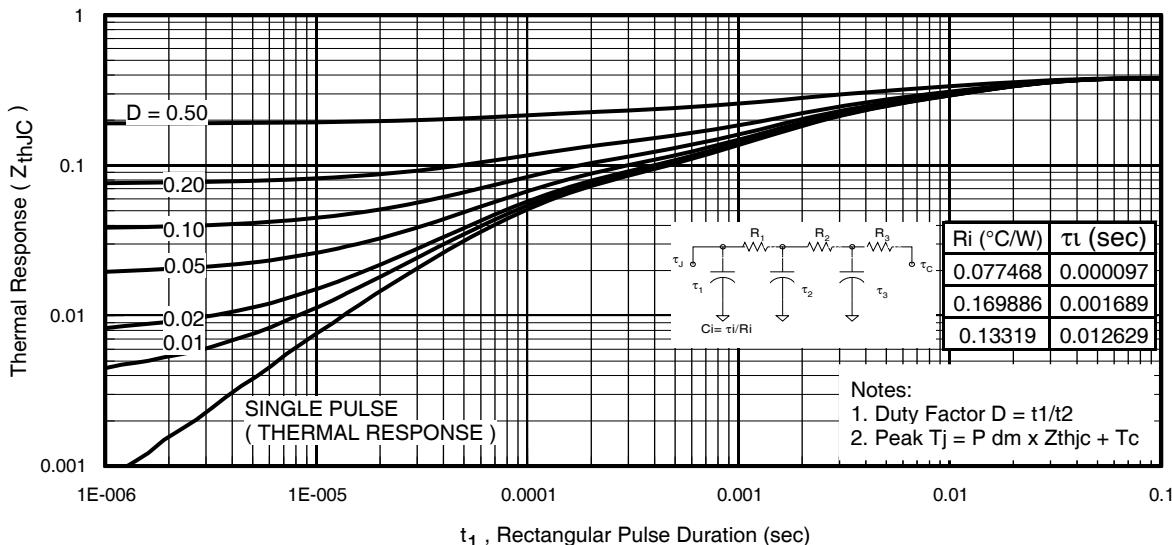
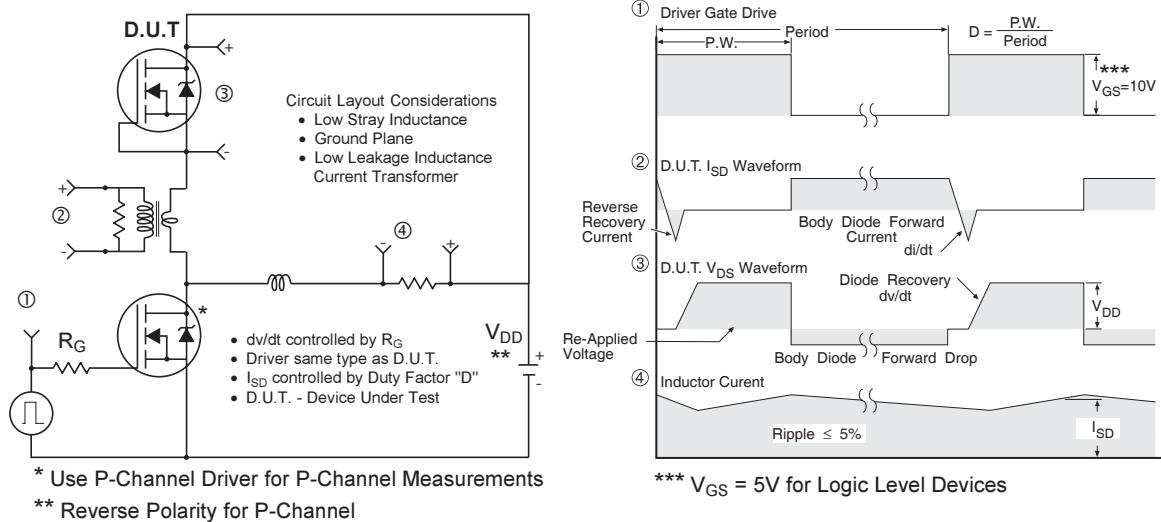
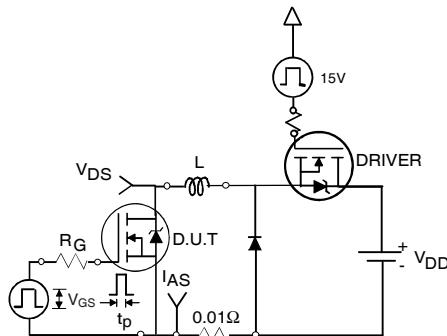


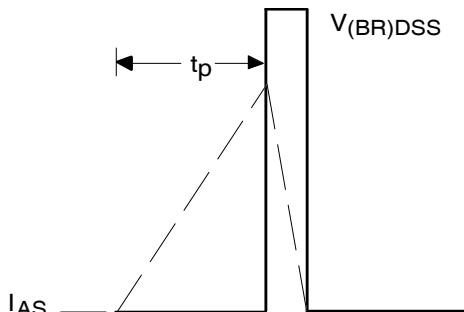
Fig 17. Maximum Effective Transient Thermal Impedance, Junction-to-Case



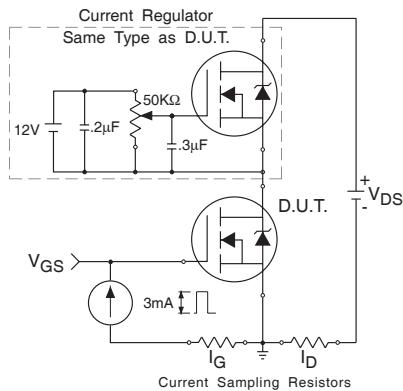
**Fig 18.** Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs



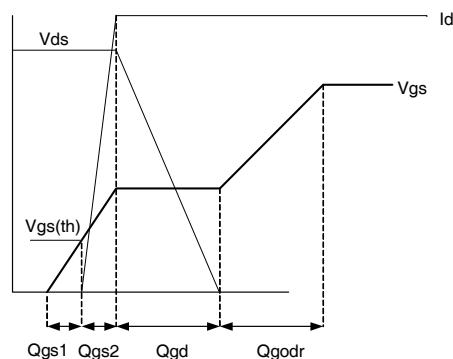
**Fig 19a.** Unclamped Inductive Test Circuit



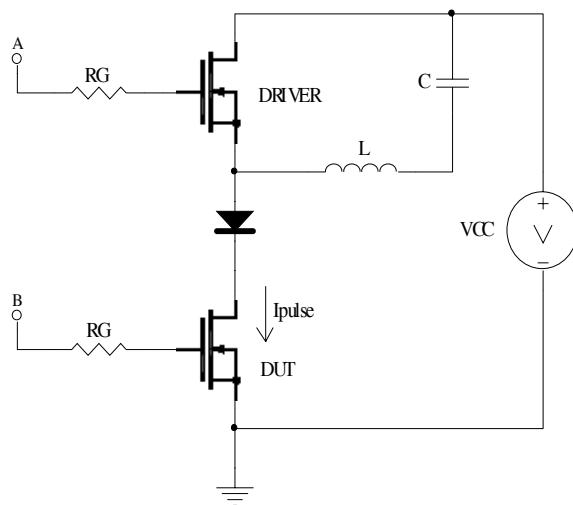
**Fig 19b.** Unclamped Inductive Waveforms



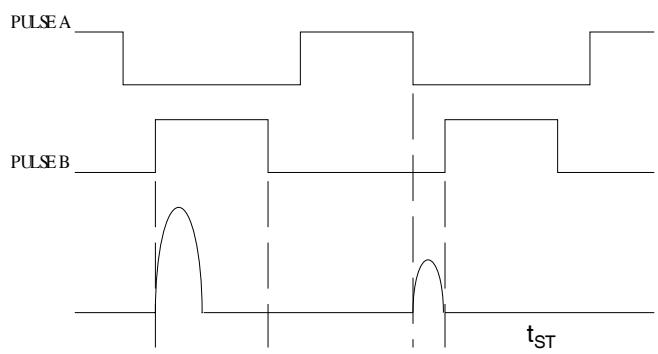
**Fig 20a.** Gate Charge Test Circuit



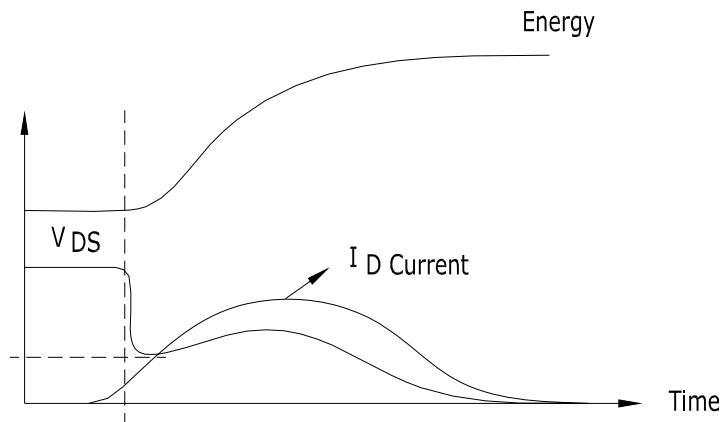
**Fig 20b.** Gate Charge Waveform



**Fig 21a.**  $t_{st}$  and  $E_{PULSE}$  Test Circuit

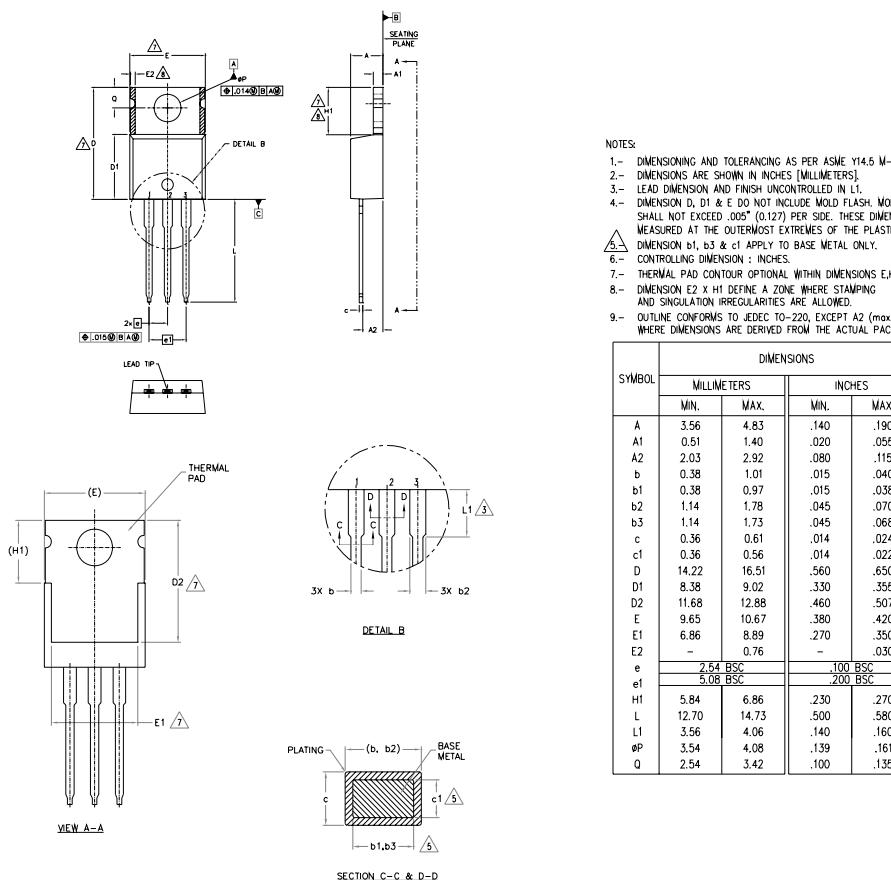


**Fig 21b.**  $t_{st}$  Test Waveforms



**Fig 21c.**  $E_{PULSE}$  Test Waveforms

## TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



SYMBOL	DIMENSIONS		NOTES
	MILLIMETERS	INCHES	
	MIN.	MAX.	
A	3.56	.483	140
A1	0.51	1.40	.020
A2	2.03	2.92	.080
b	0.38	1.01	.015
b1	0.38	0.97	.015
b2	1.14	1.78	.045
b3	1.14	1.73	.045
c	0.36	0.61	.014
c1	0.36	0.56	.014
D	14.22	16.51	.560
D1	8.38	9.02	.330
D2	11.68	12.88	.460
E	9.65	10.67	.380
E1	6.86	8.89	.270
E2	—	0.76	—
e	2.54 BSC	.100 BSC	
e1	5.08 BSC	.200 BSC	
H1	5.84	6.86	.230
L	12.70	14.73	.500
L1	3.56	4.06	.140
P	3.54	4.08	.139
Q	2.54	3.42	.100
			.135

**LEAD ASSIGNMENTS**

1- GATE
2- DRAIN
3- SOURCE

**IRFB4332**

1- ANODE
2- CATHODE
3- ANODE

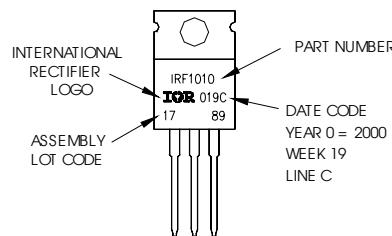
**DIODES**

1- ANODE
2- CATHODE
3- ANODE

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
LOT CODE 1789  
ASSEMBLED ON WW 19, 2000  
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position  
indicates "Lead-Free"



TO-220AB packages are not recommended for Surface Mount Application.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.39\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 35\text{A}$ .
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_\theta$  is measured at  $T_J$  of approximately  $90^\circ\text{C}$ .
- ⑤ Half sine wave with duty cycle = 0.25,  $t_{on}=1\mu\text{sec}$ .
- ⑥ Applicable to Sustain and Energy Recovery applications.

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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